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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/788,866	MOLZ ET AL.	
Examiner	Art Unit	• •
John Kim	3733	

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Class	Subclass	Date	Examiner	
87	9, 11, 13	1/12/2006	JK	-8
606	60, 74	1/12/2006	JK	
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
nventor's name search	1/12/2006	JK
East search history	1/12/2006	JK